Noise in the helical edge channel anisotropically coupled to a local spin

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We calculate the frequency-dependent shot noise in the edge states of a two-dimensional topological insulator coupled to a magnetic impurity with spin S = 1/2 of arbitrary anisotropy. If the anisotropy is absent, the noise is purely thermal at low frequencies, but tends to the Poissonian noise of the full current I at high frequencies. If the interaction only flips the impurity spin but conserves those of electrons, the noise at high voltages $eV \gg T$ is frequency-independent. Both the noise and the backscattering current I_{bs} saturate at voltage-independent values. Finally, if the Hamiltonian contains all types of non-spin-conserving scattering, the noise at high voltages becomes frequency-dependent again. At low frequencies, its ratio to $2eI_{bs}$ is larger than 1 and may reach 2 in the limit $I_{bs} \to 0$. At high frequencies it tends to 1.

1. Introduction. The suppression of quantized conductance in the edge states of two-dimensional topological insulators remains an outstanding problem. From theoretical considerations, it follows that the electronspin projection in these states is locked to the direction of its momentum and therefore the electrons cannot be backscattered if time-reversal symmetry takes place. However experiments revealed that the actual conductance of these states is much smaller than the theoretical value e^2/h^1 , which implies a presence of spin-flip processes. Different mechanisms of such processes were proposed, including capture of electrons from the helical edge states into conducting puddles in the bulk of the material^{2,3}, different combinations of spin-orbit coupling and electron-electron scattering^{4,5}, or spin-flip scattering at localized magnetic moments 6,7 . But so far, none of these mechanisms has obtained a definite experimental confirmation.

An efficient tool for determining the mechanism of conduction are measurements of nonequilibrium noise. A quantitative measure of this noise is the Fano factor $F = S_I/2eI$, where S_I is the zero frequency noise and I is dc current. For noninteracting electrons, F is always smaller than 1, so F > 1 is a signature of interaction effects in the transport. So far, most theoretical papers dealing with noise in 2D topological insulators addressed the electron tunneling between the helical states of the same chirality at opposite edges of the insulator⁸⁻¹¹. The noise in the edge states themselves due to the hyperfine interaction of the electrons with nuclear spins in a presence of nonuniform spin-orbit coupling was calculated in Ref.¹². The shot noise that results from the exchange of electrons between the edge states and conducting puddles in the bulk of the insulator was calculated in Ref.¹³. Very recently, Väyrynen and Glazman considered the current noise generated by a local magnetic moment coupled to the edge states¹⁴. These authors calculated the noise spectrum for the case of isotropic coupling by extrapolating the Nyquist relation to finite voltages. They also presented an expression for the noise in the case of vanishingly small anisotropic coupling at zero frequency and high bias.

The extrapolation of the Nyquist relation to finite voltages appears to give the correct results in the case of isotropic coupling with impurity, but it does not hold for the anisotropic case. In this paper, we microscopically calculate the non-equilibrium electrical noise for an arbitrary anisotropy of exchange coupling of the edge states to a local spin 1/2. The stochastic equation approach allows us to derive the spectral density in the classical frequencies domain, i.e. for $\hbar \omega \ll T$, and arbitrary voltage biases (the Boltzmann constant is set to 1 throughout the paper). Our results coincide with Ref.¹⁴ in the limiting cases.

2. Average current. Consider a pair of helical edge states with linear dispersion $\varepsilon(k) = \pm v_0 k$, where the upper and lower signs correspond to the two possible z components of electron spin (\uparrow and \downarrow). The edge states connect two electron reservoirs kept at constant voltages $\pm V/2$ and are coupled to a magnetic impurity via a Hamiltonian¹⁵

$$H_{int} = J_z S_z s_z + J_0 \left(S_+ s_- + S_- s_+ \right) + J_a \left(S_+ + S_- \right) s_z + J_1 S_z \left(s_+ + s_- \right) + J_2 \left(S_+ s_+ + S_- s_- \right), \quad (1)$$

where S_z , $S_{\pm} = S_x \pm iS_y$ and s_z, s_{\pm} are the operators of the impurity spin and of the spin density of electrons at its location. The first term in Eq. (1) leads only to dephasing of impurity spin. The second term leads to spin-conserving transitions, the third and fourth change the total z projection of the system spin by 1/2, and the last term changes it by 1.

We assume that the coupling is weak¹⁶ and that there is a sufficiently strong dephasing of the impurity due to the first term in Eq. (1). Therefore the dynamics of spin may be described by a master equation for the occupation numbers of the spin-up and spin-down states N_{\uparrow} and N_{\downarrow} of the form

$$\frac{dN_{\uparrow}}{dt} = \left(\Gamma_0^+ + \Gamma_a + \Gamma_2^+\right) N_{\downarrow} - \left(\Gamma_0^- + \Gamma_a + \Gamma_2^-\right) N_{\uparrow}, (2)$$
$$N_{\downarrow} = 1 - N_{\uparrow},$$

where the transition rates corresponding to the different

terms of Hamiltonian Eq. (1) are given by the Fermi golden rule. For example, the rates of spin-conserving transitions that result from the second term in Eq. (1) are

$$\Gamma_0^{\pm} = \frac{\alpha_0}{2\pi\hbar} \int d\varepsilon f_{\uparrow,\downarrow}(\varepsilon) \left[1 - f_{\downarrow,\uparrow}(\varepsilon)\right],\tag{3}$$

where $\alpha_0 = |J_0|^2/4v_0^2$ and $f_{\uparrow,\downarrow}(\varepsilon)$ are the distribution functions of spin-up and spin-down electrons incident on the impurity. The rate of transitions that conserve the projection of electron spins but flip the spin of impurity is

$$\Gamma_a = \frac{\alpha_a}{2\pi\hbar} \sum_{\nu=\uparrow,\downarrow} \int d\varepsilon f_{\nu}(\varepsilon) \left[1 - f_{\nu}(\varepsilon)\right], \qquad (4)$$

where $\alpha_a = |J_a|^2/4v_0^2$. The rates of transitions that flip both the electron and impurity spins in the same direction Γ_2^{\pm} coincide with Γ_0^{\pm} up to the replacement of α_0 by $\alpha_2 = |J_2|^2/4v_0^2$.

The electrical current through the edge states is given by the expression

$$I = I_{\uparrow}^{in} + I_{\downarrow}^{in} - e\left(\Gamma_0^+ N_{\downarrow} - \Gamma_0^- N_{\uparrow}\right) + e\left(\Gamma_1^+ - \Gamma_1^-\right) + e\left(\Gamma_2^+ N_{\downarrow} - \Gamma_2^- N_{\uparrow}\right), \quad (5)$$

where the currents injected into the edge states from the left and right reservoirs are given by equations

$$I^{in}_{\uparrow,\downarrow} = \pm \frac{e}{2\pi\hbar} \int d\varepsilon f_{\uparrow,\downarrow}(\varepsilon) \tag{6}$$

and the rest of terms describe spin-flip backscattering of electrons from the impurity, which is either accompanied by its spin flip or not. The rates of scattering events that do not change the impurity spin Γ_1^{\pm} are obtained from Γ_0^{\pm} by replacing α_0 by $\alpha_1 = |J_1|^2/4v_0^2$.

The dc current is easily obtained from the stationary solution of Eqs. (2) and (5). Because of weak coupling, one may calculate the transition rates using the unperturbed distribution functions of electrons $f_{\uparrow}(\varepsilon) = f_0(\varepsilon - eV/2)$ and $f_{\downarrow}(\varepsilon) = f_0(\varepsilon + eV/2)$, where $f_0(\varepsilon)$ is the Fermi distribution. In the most general case, it is of the form

$$I = \frac{e^2 V}{4\pi\hbar} \left(2 - \alpha_0 - 2\alpha_1 - \alpha_2\right) + \frac{e^2 V}{4\pi\hbar} \frac{(\alpha_0 - \alpha_2)^2 eV \coth\left(\frac{eV}{2T}\right)}{4\alpha_a T + (\alpha_0 + \alpha_2) eV \coth\left(\frac{eV}{2T}\right)}.$$
 (7)

The shape of negative correction to the current in the absence of scattering $I_{bs} = e^2 V/2\pi\hbar - I$ strongly depends on the coupling-parameter anisotropy in the Hamiltonian Eq. (1). If $\alpha_a = \alpha_1 = \alpha_2 = 0$, I_{bs} is also zero for any V. If $\alpha_a \neq 0$ but $\alpha_1 = \alpha_2 = 0$, I_{bs} is linearly proportional to the voltage at $eV \ll T$ but saturates to a finite value in the opposite limit. Finally if either α_1 or α_2 is nonzero, the backscattering current scales linearly with V even at high voltages.

3. Equations for the fluctuations. Because of weak coupling between the electrons and the impurity, the dynamics of the system may be treated as a Markov random process and described by differential stochastic equations. Basically, there are two sources of noise in this system. One of them is the random injection of electrons in the edge states from the reservoirs, i. e. the occupation-number noise. Taken alone, this random injection would result in the Nyquist noise of a perfect quantum channel with a spectral density $2e^2T/\pi\hbar$. Out of equilibrium, there is also another source of noise related with the randomness of electron-impurity spin-flip scattering, i. e. the partition noise¹⁷. The interference between these two sources of noise shapes its temperature and voltage dependence. The stochastic equation for the impurity spin-up occupation number is of the form

$$\frac{d\delta N_{\uparrow}}{dt} = -(\Gamma_0^+ + \Gamma_0^- + 2\Gamma_a + \Gamma_2^+ + \Gamma_2^-) \,\delta N_{\uparrow} + N_{\downarrow} \left(\delta \Gamma_0^+ + \delta \Gamma_2^+\right) - N_{\uparrow} \left(\delta \Gamma_0^- + \delta \Gamma_2^-\right) + \left(N_{\downarrow} - N_{\uparrow}\right) \delta \Gamma_a + \xi_0 + \xi_a + \xi_2, \quad (8)$$

and the corresponding Langevin equation for the fluctuation of the current is

$$\delta I = \delta I_{\uparrow}^{in} + \delta I_{\downarrow}^{in} + e \left(\Gamma_0^+ + \Gamma_0^- - \Gamma_2^+ - \Gamma_2^- \right) \delta N_{\uparrow} - e N_{\downarrow} \left(\delta \Gamma_0^+ - \delta \Gamma_2^+ \right) + e N_{\uparrow} \left(\delta \Gamma_0^- - \delta \Gamma_2^- \right) + e \left(\delta \Gamma_1^+ - \delta \Gamma_1^- \right) - e \left(\xi_0 - \xi_1 - \xi_2 \right), \quad (9)$$

where the symbol δ ... denotes the fluctuation of the corresponding quantity and the external sources ξ_0 , ξ_a , ξ_1 , and ξ_2 are the external sources, which are deltacorrelated in time and related with the scattering processes described by Γ_0^{\pm} , Γ_a , Γ_1^{\pm} , and Γ_2^{\pm} , respectively. Note that ξ_0 enters into Eqs. (8) and (9) with opposite signs because this type of scattering decreases the number of right-moving electrons as the impurity spin turns upward. In contrast to this, ξ_2 enters into both equations with the same sign because this type of scattering simultaneously increases the number of right-movers and the projection of the impurity spin on the z axis. In the limit of weak electron-impurity coupling, the spectral density of these sources is twice the sum of scattering fluxes in both directions¹⁸, i. e.

$$S_{0} = 2 \left(\Gamma_{0}^{+} N_{\downarrow} + \Gamma_{0}^{-} N_{\uparrow} \right), \quad S_{a} = 2 \Gamma_{a},$$

$$S_{1} = 2 \left(\Gamma_{1}^{+} + \Gamma_{1}^{-} \right), \quad S_{2} = 2 \left(\Gamma_{2}^{+} N_{\downarrow} + \Gamma_{2}^{-} N_{\uparrow} \right).$$
(10)

The extraneous sources related with different scattering processes are uncorrelated.

While the partition noise is described by the extraneous sources in Eqs. (8) and (9), the occupation-number noise comes into play through the fluctuations of the distribution functions of injected electrons $\delta f_{\uparrow,\downarrow}(\varepsilon)$, which result in the fluctuations of the injected currents (6) and the scattering rates, e. g.

$$\delta\Gamma_0^+ = \frac{\alpha_0}{2\pi\hbar} \int d\varepsilon \left[(1 - f_{\downarrow}) \,\delta f_{\uparrow} - f_{\uparrow} \,\delta f_{\downarrow} \right]. \tag{11}$$

The correlation function of $\delta f_{\uparrow,\downarrow}(\varepsilon)$ is well known and equals¹⁹

$$\langle \delta f_{\sigma}(t,\varepsilon) \, \delta f_{\sigma'}(t',\varepsilon') \rangle = 2\pi\hbar \, \delta_{\sigma\sigma'} \, \delta(t-t') \, \delta(\varepsilon-\varepsilon') \\ \times f_{\sigma}^{in}(\varepsilon) \, [1-f_{\sigma}^{in}(\varepsilon)], \quad (12)$$

where $\sigma = (\uparrow, \downarrow)$. These fluctuations are uncorrelated with the extraneous sources in Eqs. (8) and (9) because they originate from the depth of reservoirs due to the finite temperature in them. Equation (8) has to be solved for δN_{\uparrow} and the result has to be substituted into Eq. (9) together with $\delta N_{\downarrow} = -\delta N_{\downarrow}$. Multiplying the Fourier transform of Eq. (9) by its complex conjugate and making use of Eqs. (10) and (12), one obtains the spectral density of current noise. Because the coupling is assumed to be weak, one has to keep only the terms up to linear order in constants α . The general equation for the nonequilibrium noise is too cumbersome to be presented here, and therefore we give it only for some particular cases.

4. The equilibrium response. First of all, we calculate the equilibrium linear response of the edge states coupled to an impurity to a voltage oscillating with frequency ω . It is easily obtained from Eqs. (8) and (9) by setting $\delta f_{\uparrow,\downarrow}(\varepsilon,t) = \mp (eV/2) \exp(-i\omega t) df_0/d\varepsilon$ and dropping the extraneous sources in them. In this case, the time-averaged spin-up and spin-down occupancies of the impurity are equal to 1/2, and the frequency-dependent complex conductance of the system is given by

$$G(\omega) = \frac{e^2}{2\pi\hbar} \left[1 - \alpha_1 - \frac{\alpha_0}{2} \frac{-2\pi i \hbar \omega + 4 (\alpha_a + \alpha_2) T}{-2\pi i \hbar \omega + 2 \alpha_{\Sigma} T} - \frac{\alpha_2}{2} \frac{-2\pi i \hbar \omega + 4 (\alpha_a + \alpha_0) T}{-2\pi i \hbar \omega + 2 \alpha_{\Sigma} T} \right], \quad (13)$$

where $\alpha_{\Sigma} = \alpha_0 + 2\alpha_a + \alpha_2$. Unless $\alpha_0 = \alpha_2$, the real part of *G* monotonically decreases with ω to a finite value, while its imaginary part tends to zero both at $\omega = 0$ and high frequencies with a maximum at $\omega \sim \alpha_{\Sigma} T/\hbar$. It may be verified that the equilibrium noise calculated by our method satisfies the Nyquist theorem $S_I(\omega) =$ $4T \operatorname{Re} G(\omega)$ for arbitrary coupling constants.

5. Rotationally symmetric coupling. If the electron-impurity coupling is rotationally symmetric with respect to the z axis, the only nonzero coupling constant is J_0 and the only nonzero scattering rate is Γ_0^{\pm} . In this case, the total spin of the electrons and the impurity is conserved by the scattering, and therefore the dc current is not affected by it because the impurity cannot increase the z projection of its spin to infinity. For this reason, the spectral density of noise at zero frequency is not affected by the scattering either. At nonzero frequencies, it is of the form

$$S_{I}(\omega) = \frac{e^{2}}{\pi\hbar} \left[2T - \frac{\alpha_{0}\omega^{2}}{\omega^{2} + \tau_{0}^{-2}} \frac{eV}{\sinh(eV/T)} \right],$$

$$\tau_{0}^{-1} = \alpha_{0} \frac{eV}{2\pi\hbar} \coth\left(\frac{eV}{2T}\right).$$
(14)



FIG. 1. Fig. 1.The voltage dependence of $S_I(0)$ (solid curve) and $S_I(\infty)$ (dashed curve) for a coupling with a point-like impurity with $\alpha_0 = 1$ and $\alpha_a = 0.5$.

This is essentially the same result that was obtained in Ref.¹⁴ by extrapolating the fluctuation-dissipation relation into the nonequilibrium region. The reason why this extrapolation is valid in this particular case is that for an isotropic coupling, the effect of finite voltage difference between the reservoirs is equivalent to an external magnetic field applied to the impurity along the $z axis^{20}$. Hence the nonequilibrium system may be mapped onto an equilibrium one and the fluctuation-dissipation relation may be used.

6. Point-like impurity. The coupling may be anisotropic even for a point-like impurity and isotropic exchange interaction with bulk electrons if a finite spatial width of the edge state is taken into account and the impurity is located away from its center in the zdirection¹⁵. In this case, the coupling constant J_a is nonzero as well as J_0 , so both Γ_a and Γ_0^{\pm} have to be taken into account. The scattering process described by Γ_a leads to a relaxation of the impurity spin similarly to its contact with an external spin bath, and therefore the scattering correction to the dc current is nonzero. However Γ_a is proportional to T/\hbar , while Γ_0^+ is proportional to eV/\hbar at $eV \gg T$. This is why the backscattering current initially grows with voltage but eventually saturates at $I_{bs} = \alpha_a eT/\pi\hbar$. The nonequilibrium noise shows a similar behavior. At a given voltage, it monotonically decreases with increasing frequency to a finite value. A typical voltage dependence of the zero-frequency and highfrequency noise is shown in Fig. 1. In the zero-voltage limit, the noise decreases from

$$S_I(0) = \frac{2e^2}{\pi\hbar} \left(1 - \frac{\alpha_a \alpha_0}{\alpha_0 + 2\alpha_a} \right) T \tag{15}$$

at low frequency to

$$S_I(\infty) = \frac{e^2}{\pi\hbar} \left(2 - \alpha_0\right) T \tag{16}$$

at high frequencies. At high voltages the noise is frequency-independent and equals to

$$S_I = \frac{2e^2}{\pi\hbar} \left(1 + \alpha_a\right) T. \tag{17}$$

Note the change of sign of the inelastic correction to the noise with respect to Eqs. (15) and (16). The Fano factor of the excess noise with respect to the backscattering current $F_{bs} \equiv (S_I - 2e^2T/\pi\hbar)/2eI_{bs}$ is unity. This suggests that the backscattering of different electrons from the impurity is totally uncorrelated.

7. Coupling of arbitrary symmetry. If the impurity has a finite size, all the coupling parameters in the Hamiltonian (1) may be nonzero. The scattering rate Γ_1 leads to a backscattering of electrons without flipping the impurity spin, while the rates Γ_0^{\pm} and Γ_2^{\pm} describe electron backscattering accompanied by flips of the impurity spin in the opposite directions, which partly compensate each other. As the three scattering rates are proportional to eV/\hbar at $eV \gg T$, the backscattering current and the current noise also increase proportionally to the voltage. At low voltages, the zero-frequency noise is given by the Nyquist formula

$$S_I(0) = \frac{2e^2}{\pi\hbar} \left[1 - \alpha_1 - \frac{\alpha_a \left(\alpha_0 + \alpha_2\right) + 2\alpha_0 \alpha_2}{\alpha_0 + 2\alpha_a + \alpha_2} \right] T.(18)$$

As the voltage increases, the scattering correction to the noise becomes positive and assumes the form

$$S_I(0) = \frac{e^2}{\pi\hbar} \left[\alpha_1 + 4 \, \frac{\alpha_0 \alpha_2 \, (\alpha_0^2 + \alpha_2^2)}{(\alpha_0 + \alpha_2)^3} \right] eV.$$
(19)

Together with Eq. (7) it results in the Fano factor with respect to backscattering current

$$F_{bs} = \frac{\alpha_1 (\alpha_0 + \alpha_2)^3 + 4\alpha_0 \alpha_2 (\alpha_0^2 + \alpha_2^2)}{[\alpha_1 (\alpha_0 + \alpha_2) + 2\alpha_0 \alpha_2](\alpha_0 + \alpha_2)^2}.$$
 (20)

As well as the dc current Eq. (7), this equation is symmetric with respect to α_0 and α_2 , but there are reasons to believe that both α_1 and α_2 are smaller than α_0 in realistic systems¹⁵. A 3D plot of Eq. (20) as a function of α_1/α_0 and α_2/α_0 is shown in Fig. 2. Depending on these ratios, it varies between 1 and 2 and reaches maximum in the limit $\alpha_1 \ll \alpha_2 \ll \alpha_0$. The increase of F_{bs} above 1 suggests that the events of electron backscattering from the impurity are correlated. Indeed, if either α_2 or α_0 would be zero, the impurity would be completely polarized and no electron backscattering would be possible. If both of them are nonzero, the scattering events with the smaller rate would destroy this polarization and favor the scattering event with larger rate that will flip the impurity spin in the opposite direction¹⁴. Therefore the electron backscattering events take place in pairs and the zero-frequency noise is doubled. Note that F_{bs} decreases to unity if $\alpha_2 = \alpha_0$. A similar increase of the Fano factor above unity was observed in resonant tunneling via interacting localized states²¹.



FIG. 2. Fig. 2. A 3D plot of the Fano factor F_{bs} as a function of α_1/α_0 and α_2/α_0 .

The dispersion of the noise takes place at $\omega \sim \Gamma_0^+ + \Gamma_2^-$. At much higher frequencies and at $eV \gg T$,

$$S_I(\infty) = \frac{e^2}{\pi\hbar} \left(\alpha_1 + 2 \frac{\alpha_0 \alpha_2}{\alpha_0 + \alpha_2} \right) eV \tag{21}$$

is always smaller than $S_I(0)$ and its ratio to $2eI_{bs}$ is one. At $\alpha_1 \ll \alpha_2 \ll \alpha_0$, the frequency dependence of spectral density is consistent with a picture of a random sequence of current pulses of the form

$$I_p(t) = e \left[\sqrt{2} \,\delta(t) + (2 - \sqrt{2}) \,\Gamma_0 \,\Theta(t) \exp(-\Gamma_0 t) \right], (22)$$

which carry a charge of 2e each.

8. Conclusion. So far, there were not many experimental results on electrical noise in the edge states of 2D topological insulators. The only paper we are aware of is Ref.²², which reported the conductance much smaller than e^2/\hbar and the Fano factor smaller than one. Still our results may be compatible with these findings if one assumes that the backscattering is caused by many local moments randomly distributed along the edge states. In this case, the Fano factor with respect to the transport current would reduce to 1/3, as in conventional diffusive conductors. To test the current theory, one could controllably implant magnetic impurities like Mn near the edges of a topological insulator.

In summary, we have calculated the nonequilibrium electric noise in a pair of edge states in a 2D topological insulator with coupling to a magnetic impurity of arbitrary anisotropy at classical frequencies. For the rotationally symmetric coupling, the noise deviates from the equilibrium one only at finite frequencies. If a point-like impurity is located away from the middle plane of the 2D insulator, both the backscattering current and nonequilibrium noise increase with voltage to a finite value proportional to the temperature. The Fano factor with respect to the backscattering current is unity in this case. If the coupling has an arbitrary symmetry, the noise grows linearly with voltage and the Fano factor ranges between 1 and 2 depending on the ratio between different coupling parameters. For a particular choice of these parameters, the backscattering current can be viewed as random sequence of pulses of asymmetric shape, each carrying a charge 2e.

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